## Search Notes



Application/Control No.	Applicant(s)/Patent Under
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MAYO ET AL.

Examiner

Art Unit

Wai, Eric C

2195

## SEARCHED

Class	Subclass	Date	Examiner		
709	229, 219	03/07/07	ECW		
713	324	03/07/07	ECW		
600	407	03/07/07	ECW		
718	102-105	4/17/2008	ECW		

## **SEARCH NOTES**

Search Notes	Date	Examiner	
Inventor's Name Search	03/07/07	ECW	
East Search	03/07/07	ECW	
Updated Search	10/10/2007	ECW	
Google Scholar Search	10/10/2007	ECW	
Updated East Search	4/17/2008	ECW	

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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